

(Legal Instruments Examiner) (Date)

Application/Control	No
10/553 059	

10/553,958

Applicant(s)/Patent under Reexamination

SAIKI ET AL.

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NONE

Art Unit 1791

Examiner Mathieu D. Vargot

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	INTERNATIONAL CLASSIFICATION .												
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(Assistant Examiner) (Date) Pr					athieu D. Vargot/ imary Examiner				Total Claims Allowed: 3				
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(Primary Examiner)

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